

CSD97374Q4M 同步降压 NexFET™ 功率级

Not Recommended for New Designs

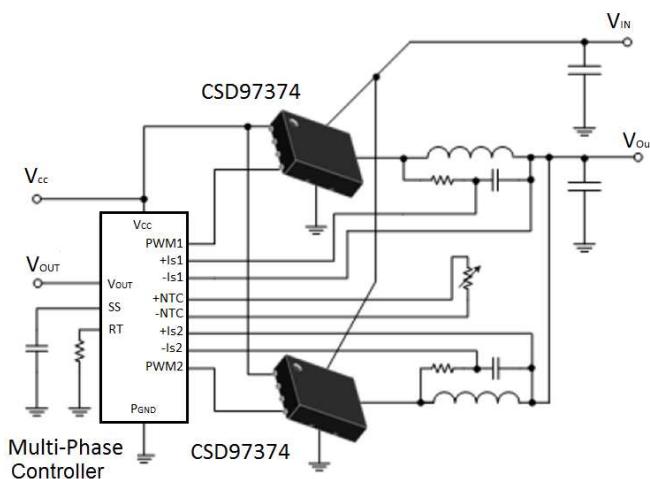
1 特性

- 15A 电流下超过 92% 的系统效率
- 最大额定持续电流 25A, 峰值 60A
- 高频运行 (高达 2MHz)
- 高密度 3.5mm x 4.5mm 小外形尺寸无引线 (SON) 封装
- 超低电感封装
- 系统已优化的印刷电路板 (PCB) 封装
- 超低静态 (ULQ) 电流模式
- 兼容 3.3V 和 5V PWM 信号
- 支持 FCCM 的二极管仿真模式
- 输入电压高达 24V
- 三态 PWM 输入
- 集成型自举二极管
- 击穿保护
- 符合 RoHS 环保标准 – 无铅引脚镀层
- 无卤素

2 应用

- 超级本/笔记本 DC/DC 转换器
- 多相 Vcore 和 DDR 解决方案
- 在网络互联、电信、和计算系统中的负载点同步降压

应用图表



3 说明

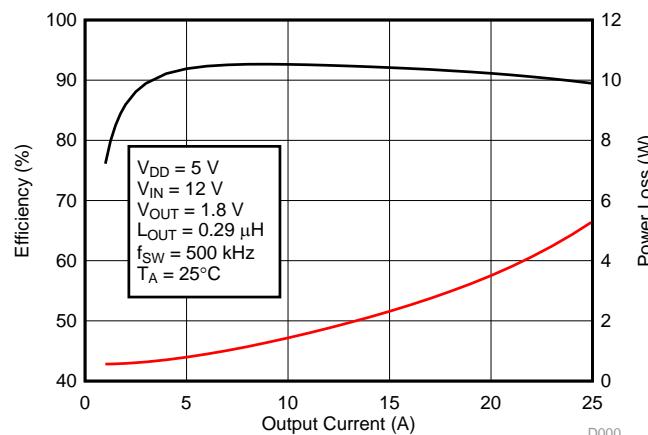
CSD97374Q4M NexFET™ 功率器件是经过高度优化的设计，用于高功率、高密度场合的同步降压转换器。这个产品集成了驱动器集成电路 (IC) 和 NexFET 技术来完善功率级开关功能。此驱动器 IC 具有一个内置可选二极管仿真功能，此功能可启用断续传导模式 (DCM) 运行来提升轻负载效率。此外，驱动器 IC 支持 ULQ 模式，此模式支持针对 Windows™8 的联网待机功能。借助于三态 PWM 输入，静态电流可减少至 $130\mu\text{A}$ ，并支持立即响应。当 SKIP# 保持在三态时，电流可减少至 $8\mu\text{A}$ (恢复切换通常需要 $20\mu\text{s}$)。该组合在小型 3.5mm x 4.5mm 外形尺寸封装中实现高电流、高效率和高速开关器件。此外，PCB 封装已经过优化，可帮助减少设计时间并简化总体系统设计。

器件信息⁽¹⁾

器件	数量	包装介质	封装	发货
CSD97374Q4M	2500	13 英寸卷带	小外形尺寸无引线 (SON) 3.50mm x 4.50mm 塑料封装	卷带封装

(1) 要了解所有可用封装，请参见数据表末尾的可订购产品附录。

典型功率级效率与功率损耗



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision C (July 2013) to Revision D

Page

•	Added description of internal connection to pin 7 in the Pin Functions table	3
•	Added ESD Ratings table	4
•	Added a NOTE to the Application and Implementation section	11
•	Added Layout section	14
•	已添加 添加了 器件和文档支持 部分	16
•	已更改 将 机械数据 部分更改成了 机械封装和可订购信息 部分	17

Changes from Revision B (May 2013) to Revision C

Page

•	在机械数据表中添加了尺寸行 b2	17
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Changes from Revision A (March 2013) to Revision B

Page

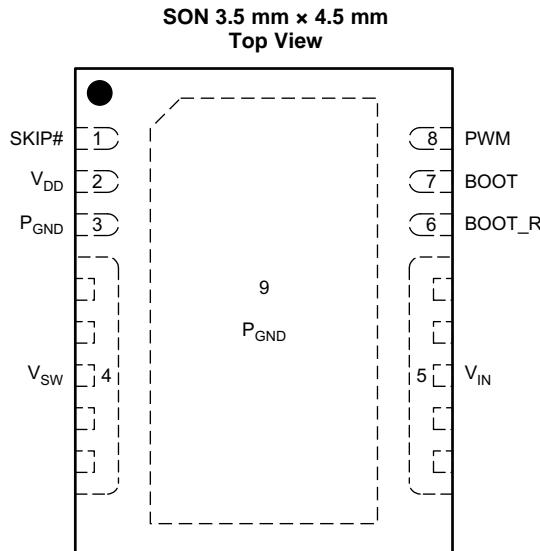
•	更改了机械制图图像	17
•	更改了推荐 PCB 焊盘布局图案	18
•	更改了推荐模版开孔图案	18

Changes from Original (January 2013) to Revision A

Page

•	Changed the ROC table, From: V_{SW} to P_{GND} , V_{IN} to V_{SW} ($<20\text{ns}$) MIN = -5 To: V_{SW} to P_{GND} , V_{IN} to V_{SW} ($<10\text{ns}$) MIN = -7	4
•	Changed the ROC table, From: BOOT to P_{GND} ($<20\text{ns}$) MIN = -3 To: BOOT to P_{GND} ($<10\text{ns}$) MIN = -2	4
•	Changed Logic Level High, V_{IH} From: MAX = 2.6 To: MIN = 2.65	5
•	Changed Logic Level Low, V_{IL} From: MIN = 0.6 To: MAX = 0.6	5
•	Changed Tri-State Voltage, V_{TS} From: MIN = 1.2 To: MIN = 1.3	5

5 Pin Configuration and Functions



Pin Functions

PIN		DESCRIPTION
NO.	NAME	
1	SKIP#	This pin enables the diode emulation function. When this pin is held low, diode emulation mode is enabled for the sync FET. When SKIP# is high, the CSD97374Q4M operates in forced continuous conduction mode. A tri-state voltage on SKIP# puts the driver into a very low power state.
2	V _{DD}	Supply voltage to gate drivers and internal circuitry.
3	P _{GND}	Power ground. Needs to be connected to Pin 9 and PCB.
4	V _{SW}	Voltage switching node. Pin connection to the output inductor.
5	V _{IN}	Input voltage pin. Connect input capacitors close to this pin.
6	BOOT_R	Bootstrap capacitor connection. Connect a minimum 0.1- μ F 16-V X5R ceramic cap from BOOT to BOOT_R pins. The bootstrap capacitor provides the charge to turn on the control FET. The bootstrap diode is integrated. Boot_R is internally connected to V _{SW} .
7	BOOT	Pulse width modulated tri-state input from external controller. Logic low sets control FET gate low and sync FET gate high. Logic high sets control FET gate high and sync FET gate low. Open or Hi-Z sets both MOSFET gates low if greater than the tri-state shutdown hold-off time (t _{3HT}).
8	PWM	
9	P _{GND}	Power ground.

6 Specifications

6.1 Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$ (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V_{IN} to P_{GND}		-0.3	30	V
V_{SW} to P_{GND} , V_{IN} to V_{SW}		-0.3	30	V
V_{SW} to P_{GND} , V_{IN} to V_{SW} (< 10 ns)		-7	33	V
V_{DD} to P_{GND}		-0.3	6	V
PWM, SKIP# to P_{GND}		-0.3	6	V
BOOT to P_{GND}		-0.3	35	V
BOOT to P_{GND} (< 10 ns)		-2	38	V
BOOT to BOOT_R		-0.3	6	V
BOOT to BOOT_R (duty cycle < 0.2 %)			8	V
P_D	Power dissipation		8	W
T_J	Operating temperature	-40	150	°C
T_{STG}	Storage temperature	-55	150	°C

(1) Stresses above those listed in *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

$T_A = 25^\circ\text{C}$ (unless otherwise noted)

		MIN	MAX	UNIT
V_{DD}	Gate drive voltage	4.5	5.5	V
V_{IN}	Input supply voltage		24	V
I_{OUT}	Continuous output current	$V_{IN} = 12\text{ V}$, $V_{DD} = 5\text{ V}$, $V_{OUT} = 1.8\text{ V}$, $f_{SW} = 500\text{ kHz}$, $L_{OUT} = 0.29\text{ }\mu\text{H}$ ⁽¹⁾	25	A
I_{OUT-PK}	Peak output current ⁽²⁾		60	A
f_{SW}	Switching frequency	$C_{BST} = 0.1\text{ }\mu\text{F}$ (min)	2000	kHz
	On-time duty cycle		85	%
	Minimum PWM on-time	40		ns
	Operating temperature	-40	125	°C

(1) Measurement made with six 10- μF (TDK C3216X5R1C106KT or equivalent) ceramic capacitors placed across V_{IN} to P_{GND} pins.
 (2) System conditions as defined in Note 1. Peak output current is applied for $t_p = 10\text{ ms}$, duty cycle $\leq 1\%$.

6.4 Thermal Information

$T_A = 25^\circ\text{C}$ (unless otherwise noted)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal resistance, junction-to-case (top of package) ⁽¹⁾			22.8	°C/W
$R_{\theta JB}$	Thermal resistance, junction-to-board ⁽²⁾			2.5	°C/W

(1) $R_{\theta JC}$ is determined with the device mounted on a 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu pad on a 1.5-in \times 1.5-in, 0.06-in (1.52-mm) thick FR4 board.
 (2) $R_{\theta JB}$ value based on hottest board temperature within 1 mm of the package.

6.5 Electrical Characteristics

$T_A = 25^\circ\text{C}$, $V_{DD} = \text{POR}$ to 5.5 V (unless otherwise noted)

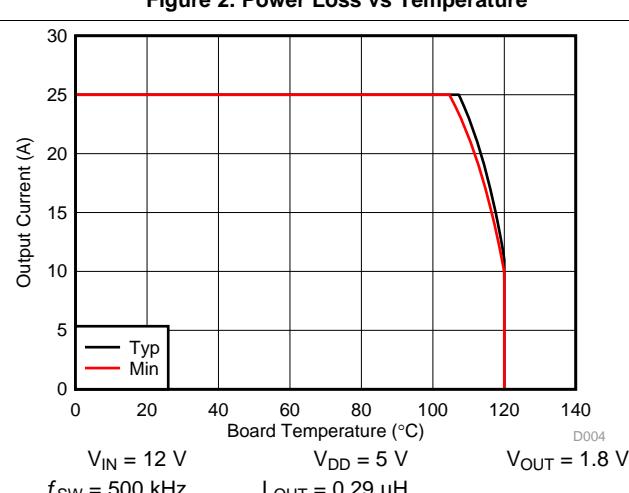
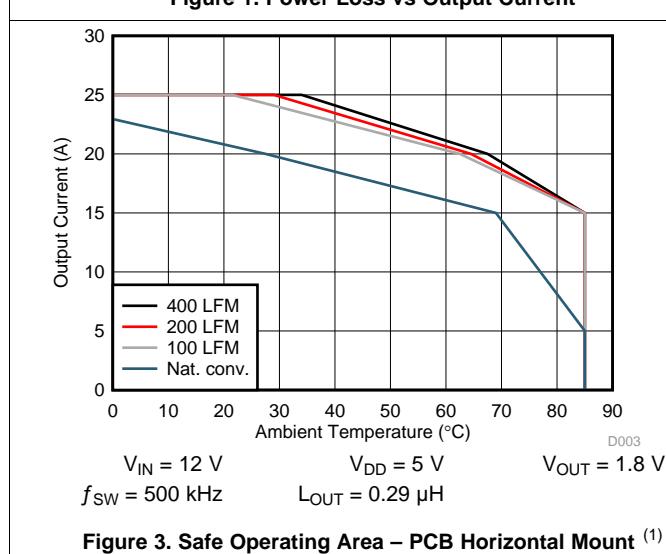
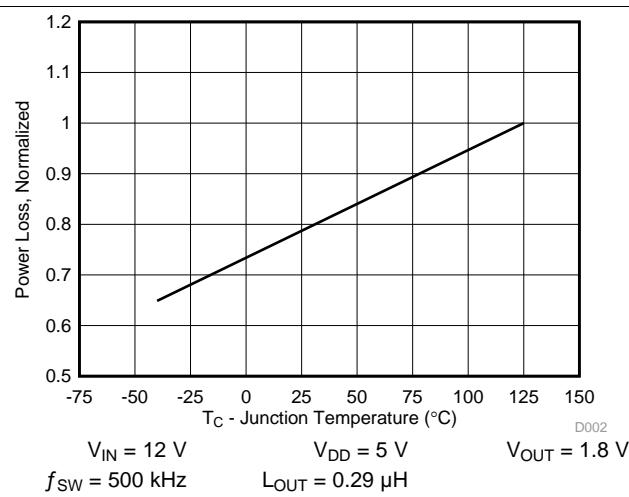
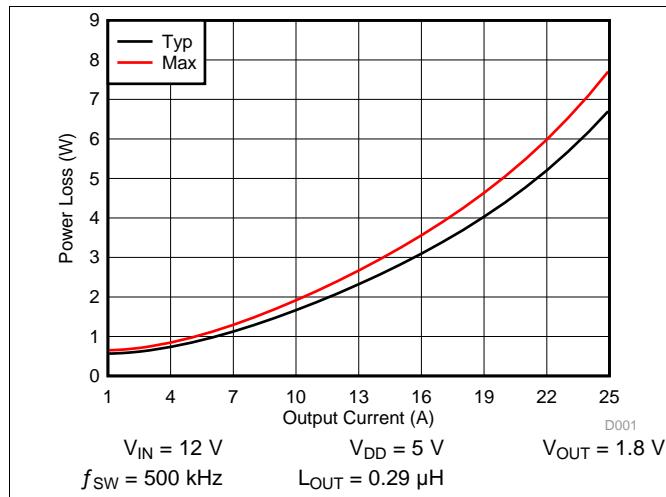
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT	
P_{LOSS}						
Power loss ⁽¹⁾	$V_{IN} = 12 \text{ V}$, $V_{DD} = 5 \text{ V}$, $V_{OUT} = 1.8 \text{ V}$, $I_{OUT} = 15 \text{ A}$, $f_{SW} = 500 \text{ kHz}$, $L_{OUT} = 0.29 \mu\text{H}$, $T_J = 25^\circ\text{C}$	2.3			W	
Power loss ⁽²⁾	$V_{IN} = 19 \text{ V}$, $V_{DD} = 5 \text{ V}$, $V_{OUT} = 1.8 \text{ V}$, $I_{OUT} = 15 \text{ A}$, $f_{SW} = 500 \text{ kHz}$, $L_{OUT} = 0.29 \mu\text{H}$, $T_J = 25^\circ\text{C}$	2.5			W	
Power loss ⁽²⁾	$V_{IN} = 19 \text{ V}$, $V_{DD} = 5 \text{ V}$, $V_{OUT} = 1.8 \text{ V}$, $I_{OUT} = 15 \text{ A}$, $f_{SW} = 500 \text{ kHz}$, $L_{OUT} = 0.29 \mu\text{H}$, $T_J = 125^\circ\text{C}$	2.8			W	
V_{IN}						
I_Q	V_{IN} quiescent current	$\text{PWM} = \text{floating}$, $V_{DD} = 5 \text{ V}$, $V_{IN} = 24 \text{ V}$		1	μA	
V_{DD}						
I_{DD}	Standby supply current	$\text{PWM} = \text{float}$, $\text{SKIP\#} = V_{DD}$ or 0 V	130		μA	
		$\text{SKIP\#} = \text{float}$	8			
I_{DD}	Operating supply current	$\text{PWM} = 50\% \text{ duty cycle}$, $f_{SW} = 500 \text{ kHz}$		8.2	mA	
POWER-ON RESET AND UNDERVOLTAGE LOCKOUT						
V_{DD} rising	Power-on reset			4.15	V	
V_{DD} falling	UVLO			3.7	V	
Hysteresis				0.2	mV	
PWM AND SKIP# I/O SPECIFICATIONS						
R_I	Input impedance	Pullup to V_{DD}	1700		$\text{k}\Omega$	
		Pulldown (to GND)	800			
V_{IH}	Logic level high			2.65	V	
V_{IL}	Logic level low			0.6	V	
V_{IH}	Hysteresis			0.2	V	
V_{TS}	Tri-state voltage			1.3	2	V
$t_{THOLD(off1)}$	Tri-state activation time (falling) PWM			60	ns	
$t_{THOLD(off2)}$	Tri-state activation time (rising) PWM			60	ns	
t_{TSKF}	Tri-state activation time (falling) SKIP#			1	μs	
t_{TSKR}	Tri-state activation time (rising) SKIP#			1	μs	
$t_{3RD(PWM)}^{(2)}$	Tri-state exit time PWM			100	ns	
$t_{3RD(SKIP\#)}^{(2)}$	Tri-state exit time SKIP#			50	μs	
BOOTSTRAP SWITCH						
V_{FBST}	Forward voltage	$I_F = 10 \text{ mA}$	120	240	mV	
$I_{RLEAK}^{(2)}$	Reverse leakage	$V_{BST} - V_{DD} = 25 \text{ V}$	2		μA	

(1) Measurement made with six 10 μF (TDK C3216X5R1C106KT or equivalent) ceramic capacitors placed across V_{IN} to P_{GND} pins.

(2) Specified by design.

6.6 Typical Characteristics

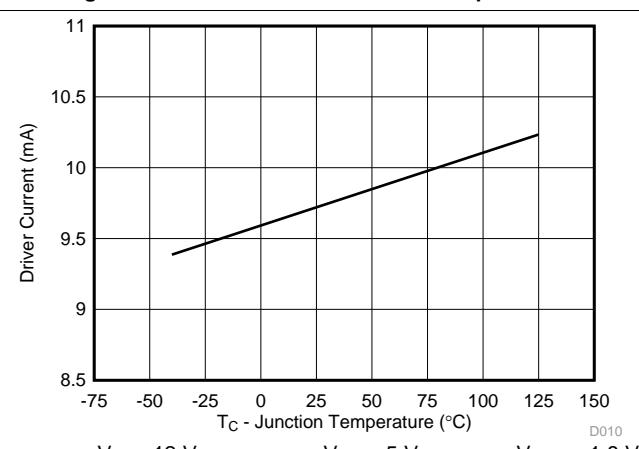
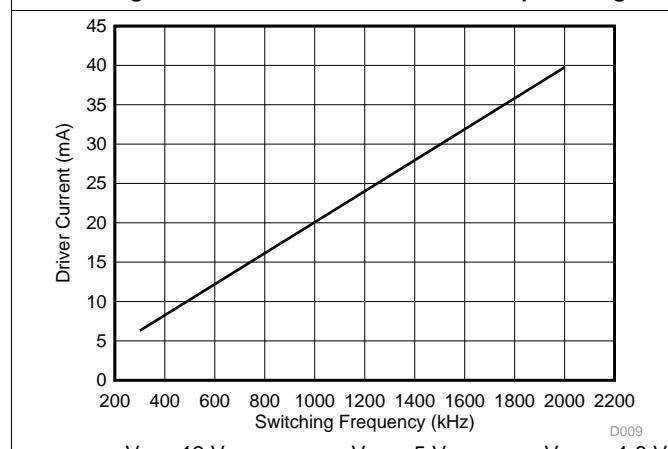
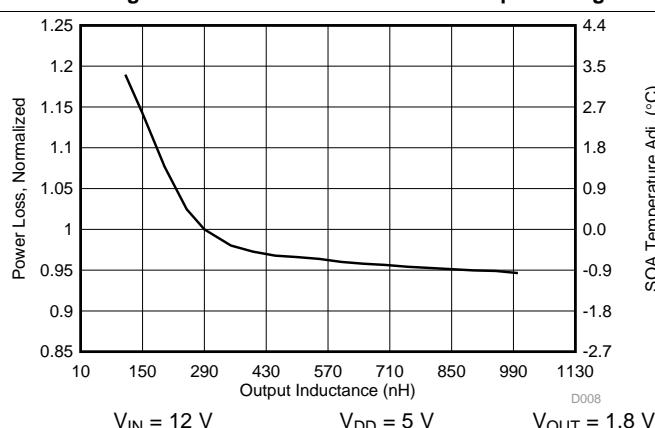
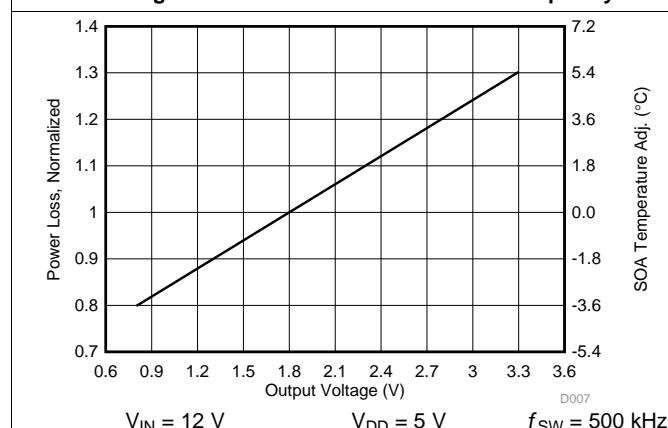
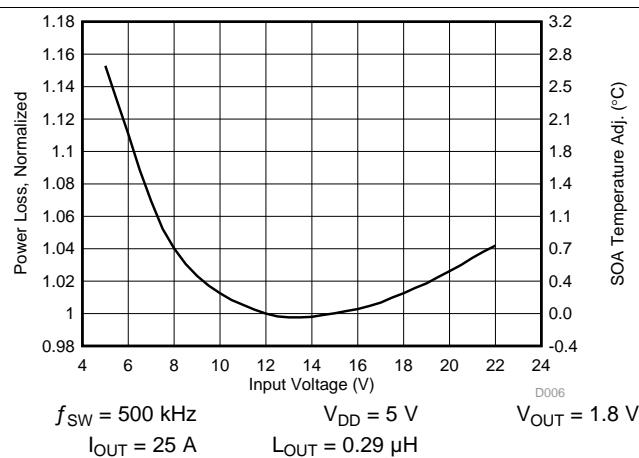
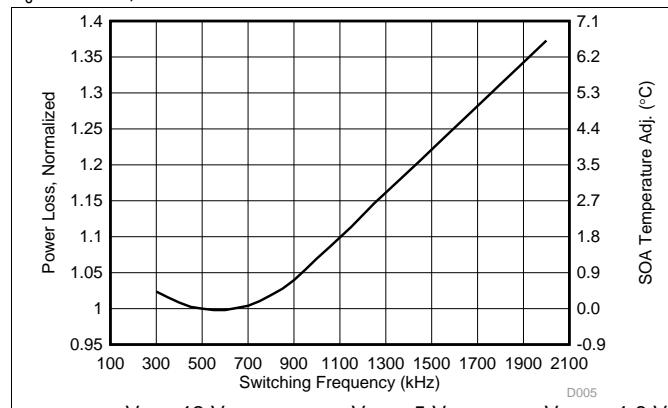
$T_J = 125^\circ\text{C}$, unless stated otherwise.



(1) The Typical CSD97374Q4M system characteristic curves are based on measurements made on a PCB design with dimensions of 4 in (W) x 3.5 in (L) x 0.062 in (T) and 6 copper layers of 1-oz copper thickness. See the [Application and Implementation](#) section for detailed explanation.

Typical Characteristics (continued)

$T_J = 125^\circ\text{C}$, unless stated otherwise.



7 Detailed Description

7.1 Functional Block Diagram

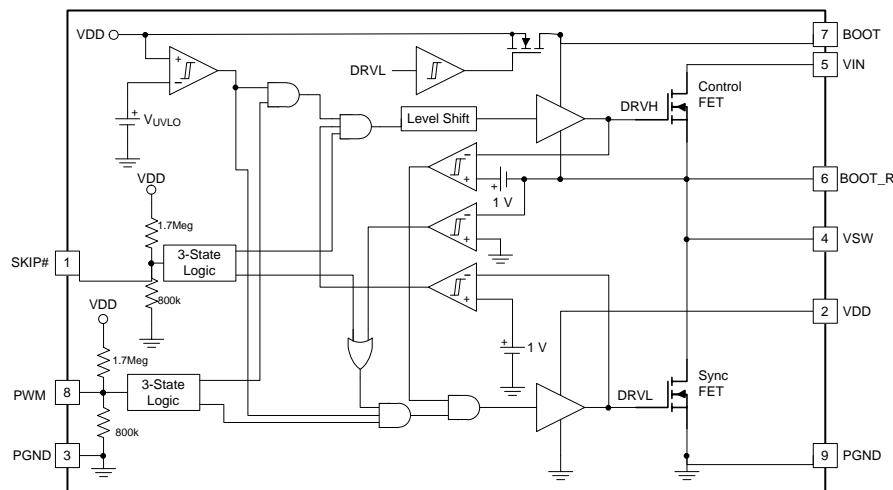


Figure 11. Functional Block Diagram

7.2 Powering CSD97374Q4M and Gate Drivers

An external V_{DD} voltage is required to supply the integrated gate driver IC and provide the necessary gate drive power for the MOSFETs. A 1- μ F 10-V X5R or higher ceramic capacitor is recommended to bypass V_{DD} pin to P_{GND} . A bootstrap circuit to provide gate drive power for the control FET is also included. The bootstrap supply to drive the control FET is generated by connecting a 100-nF 16-V X5R ceramic capacitor between $BOOT$ and $BOOT_R$ pins. An optional R_{BOOT} resistor can be used to slow down the turnon speed of the control FET and reduce voltage spikes on the V_{SW} node. A typical 1- Ω to 4.7- Ω value is a compromise between switching loss and V_{SW} spike amplitude.

7.3 Undervoltage Lockout Protection (UVLO)

The undervoltage lockout (UVLO) comparator evaluates the V_{DD} voltage level. As V_{DD} rises, both the control FET and sync FET gates hold actively low at all times until V_{VDD} reaches the higher UVLO threshold (V_{UVLO_H}). Then the driver becomes operational and responds to PWM and SKIP# commands. If V_{DD} falls below the lower UVLO threshold ($V_{UVLO_L} = V_{UVLO_H} - \text{hysteresis}$), the device disables the driver and drives the outputs of the control FET and sync FET gates actively low. Figure 12 shows this function.

CAUTION

Do not start the driver in the very low power mode (SKIP# = tri-state).

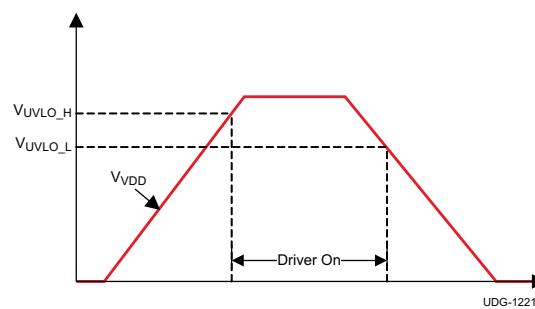


Figure 12. UVLO Operation

7.4 PWM Pin

The PWM pin incorporates an input tri-state function. The device forces the gate driver outputs to low when PWM is driven into the tri-state window and the driver enters a low-power state with zero exit latency. The pin incorporates a weak pullup to maintain the voltage within the tri-state window during low-power modes. Operation into and out of tri-state mode follows the timing diagram outlined in [Figure 13](#).

When VDD reaches the UVLO_H level, a tri-state voltage range (window) is set for the PWM input voltage. The window is defined the PWM voltage range between PWM logic high (V_{IH}) and logic low (V_{IL}) thresholds. The device sets high-level input voltage and low-level input voltage threshold levels to accommodate both 3.3-V (typical) and 5-V (typical) PWM drive signals.

When the PWM exits tri-state, the driver enters CCM for a period of 4 μ s, regardless of the state of the SKIP# pin. Normal operation requires this time period in order for the auto-zero comparator to resume.

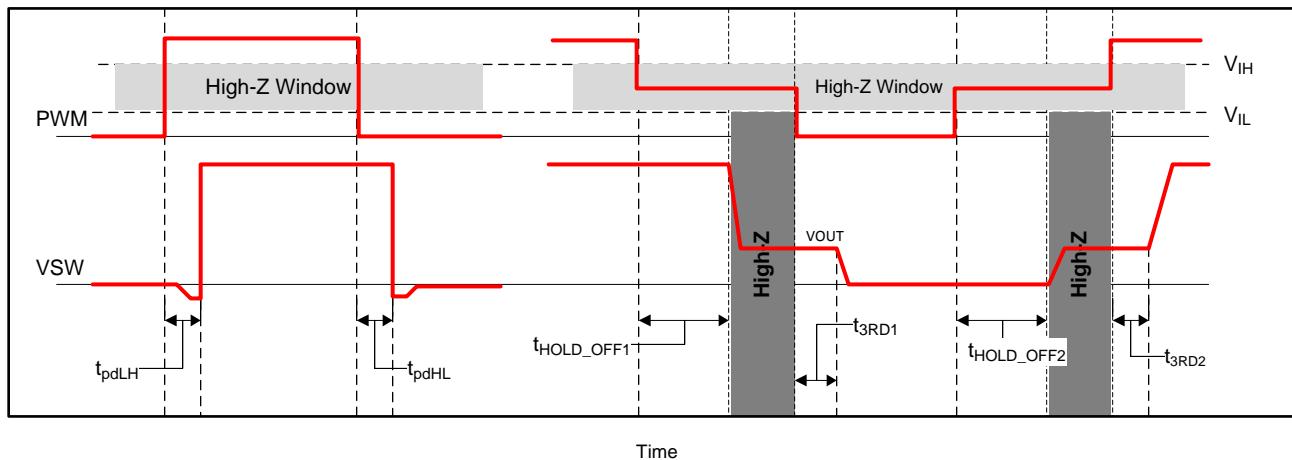


Figure 13. PWM Tri-State Timing Diagram

7.5 SKIP# Pin

The SKIP# pin incorporates the input tri-state buffer as PWM. The function is somewhat different. When SKIP# is low, the zero crossing (ZX) detection comparator is enabled, and DCM mode operation occurs if the load current is less than the critical current. When SKIP# is high, the ZX comparator disables, and the converter enters FCCM mode. When both SKIP# and PWM are tri-stated, normal operation forces the gate driver outputs low and the driver enters a low-power state. In the low-power state, the UVLO comparator remains off to reduce quiescent current. When SKIP# is pulled low, the driver wakes up and is able to accept PWM pulses in less than 50 μ s.

[Table 1](#) shows the logic functions of UVLO, PWM, SKIP#, the control FET gate and the sync FET gate.

Table 1. Logic Functions of the Driver IC

UVLO	PWM	SKIP#	SYNC FET GATE	CONTROL FET GATE	MODE
Active	—	—	Low	Low	Disabled
Inactive	Low	Low	High ⁽¹⁾	Low	DCM ⁽¹⁾
Inactive	Low	High	High	Low	FCCM
Inactive	High	H or L	Low	High	
Inactive	Tri-state	H or L	Low	Low	LQ
Inactive	—	Tri-state	Low	Low	ULQ

(1) Until zero crossing protection occurs.

7.5.1 Zero Crossing (ZX) Operation

The zero crossing comparator is adaptive for improved accuracy. As the output current decreases from a heavy load condition, the inductor current also reduces and eventually arrives at a *valley*, where it touches zero current, which is the boundary between continuous conduction and discontinuous conduction modes. The SW pin detects the zero-current condition. When this zero inductor current condition occurs, the ZX comparator turns off the rectifying MOSFET.

7.6 Integrated Boost-Switch

To maintain a BST-SW voltage close to VDD (to get lower conduction losses on the high-side FET), the conventional diode between the VDD pin and the BST pin is replaced by a FET which is gated by the DRVL signal.

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The power stage CSD97374Q4M is a highly optimized design for synchronous buck applications using NexFET devices with a 5-V gate drive. The control FET and sync FET silicon are parametrically tuned to yield the lowest power loss and highest system efficiency. As a result, a rating method is used that is tailored towards a more systems-centric environment. The high-performance gate driver IC integrated in the package helps minimize the parasitics and results in extremely fast switching of the power MOSFETs. System-level performance curves such as power loss, safe operating area and normalized graphs allow engineers to predict the product performance in the actual application.

8.2 Power Loss Curves

MOSFET centric parameters such as $R_{DS(ON)}$ and Q_{gd} are primarily needed by engineers to estimate the loss generated by the devices. In an effort to simplify the design process for engineers, Texas Instruments has provided measured power loss performance curves. [Figure 1](#) plots the power loss of the CSD97374Q4M as a function of load current. This curve is measured by configuring and running the CSD97374Q4M as it would be in the final application (see [Figure 14](#)). The measured power loss is the CSD97374Q4M device power loss which consists of both input conversion loss and gate drive loss. [Equation 1](#) is used to generate the power loss curve.

$$\text{Power loss} = (V_{IN} \times I_{IN}) + (V_{DD} \times I_{DD}) - (V_{SW_AVG} \times I_{out}) \quad (1)$$

The power loss curve in [Figure 1](#) is measured at the maximum recommended junction temperature of $T_J = 125^\circ\text{C}$ under isothermal test conditions.

8.3 Safe Operating Curves (SOA)

The SOA curves in the CSD97374Q4M data sheet give engineers guidance on the temperature boundaries within an operating system by incorporating the thermal resistance and system power loss. [Figure 3](#) and [Figure 4](#) outline the temperature and airflow conditions required for a given load current. The area under the curve dictates the safe operating area. All the curves are based on measurements made on a PCB design with dimensions of 4 in (W) \times 3.5 in (L) \times 0.062 in (T) and 6 copper layers of 1-oz copper thickness.

8.4 Normalized Curves

The normalized curves in the CSD97374Q4M data sheet give engineers guidance on the power loss and SOA adjustments based on their application specific needs. These curves show how the power loss and SOA boundaries will adjust for a given set of systems conditions. The primary Y-axis is the normalized change in power loss and the secondary Y-axis is the change in system temperature required in order to comply with the SOA curve. The change in power loss is a multiplier for the power loss curve and the change in temperature is subtracted from the SOA curve.

Normalized Curves (continued)

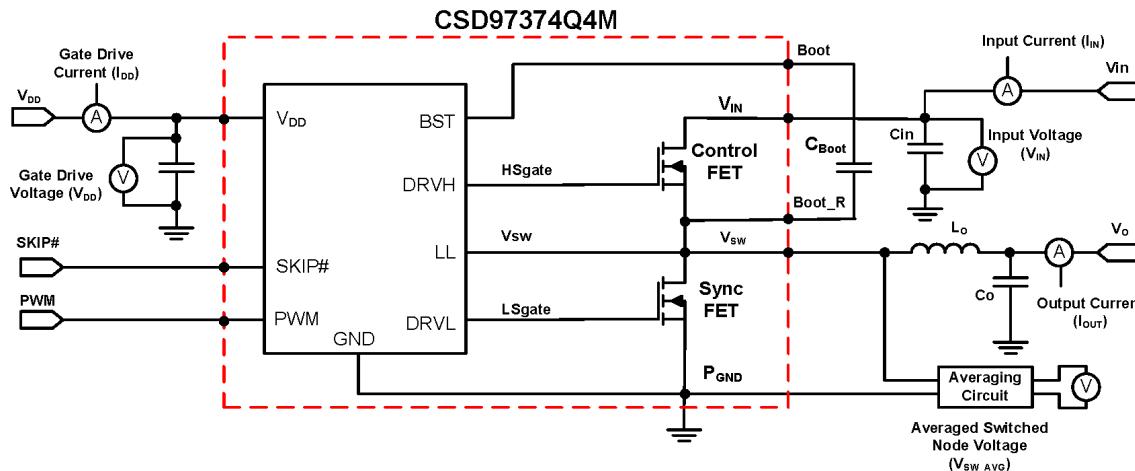


Figure 14. Power Loss Test Circuit

8.5 Calculating Power Loss and SOA

The user can estimate product loss and SOA boundaries by arithmetic means (see [Design Example](#)). Though the power loss and SOA curves in this data sheet are taken for a specific set of test conditions, the following procedure will outline the steps engineers should take to predict product performance for any set of system conditions.

8.5.1 Design Example

Operating conditions: output current (I_{OUT}) = 15 A, input voltage (V_{IN}) = 7 V, output voltage (V_{OUT}) = 1.5 V, switching frequency (f_{SW}) = 800 kHz, output inductor (L_{OUT}) = 0.2 μ H

8.5.2 Calculating Power Loss

- Typical power loss at 15 A = 2.8 W ([Figure 1](#))
- Normalized power loss for switching frequency ≈ 1.02 ([Figure 5](#))
- Normalized power loss for input voltage ≈ 1.07 ([Figure 6](#))
- Normalized power loss for output voltage ≈ 0.94 ([Figure 7](#))
- Normalized power loss for output inductor ≈ 1.08 ([Figure 8](#))
- **Final calculated power loss = $2.8 \text{ W} \times 1.02 \times 1.07 \times 0.94 \times 1.08 \approx 3.1 \text{ W}$**

8.5.3 Calculating SOA Adjustments

- SOA adjustment for switching frequency $\approx 0.3^\circ\text{C}$ ([Figure 5](#))
- SOA adjustment for input voltage $\approx 1.2^\circ\text{C}$ ([Figure 6](#))
- SOA adjustment for output voltage $\approx -1.1^\circ\text{C}$ ([Figure 7](#))
- SOA adjustment for output inductor $\approx 1.4^\circ\text{C}$ ([Figure 8](#))
- **Final calculated SOA adjustment = $0.3 + 1.2 + (-1.1) + 1.4 \approx 1.8^\circ\text{C}$**

Calculating Power Loss and SOA (continued)

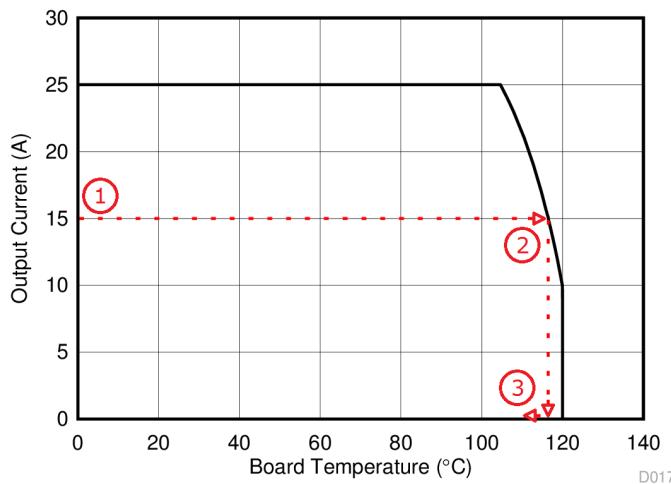


Figure 15. Power Stage CSD97374Q4M SOA

In the design example above, the estimated power loss of the CSD97374Q4M would increase to 3.1 W. In addition, the maximum allowable board and/or ambient temperature would have to decrease by 1.8°C. [Figure 15](#) graphically shows how the SOA curve would be adjusted accordingly.

1. Start by drawing a horizontal line from the application current to the SOA curve.
2. Draw a vertical line from the SOA curve intercept down to the board/ambient temperature.
3. Adjust the SOA board/ambient temperature by subtracting the temperature adjustment value.

In the design example, the SOA temperature adjustment yields a reduction in allowable board/ambient temperature of 1.8°C. In the event the adjustment value is a negative number, subtracting the negative number would yield an increase in allowable board/ambient temperature.

9 Layout

9.1 Layout Guidelines

9.1.1 Recommended PCB Design Overview

There are two key system-level parameters that can be addressed with a proper PCB design: electrical and thermal performance. Properly optimizing the PCB layout will yield maximum performance in both areas. Below is a brief description on how to address each parameter.

9.1.2 Electrical Performance

The CSD97374Q4M has the ability to switch at voltage rates greater than 10 kV/μs. Special care must be then taken with the PCB layout design and placement of the input capacitors, inductor and output capacitors.

- The placement of the input capacitors relative to V_{IN} and P_{GND} pins of CSD97374Q4M device should have the highest priority during the component placement routine. It is critical to minimize these node lengths. As such, ceramic input capacitors need to be placed as close as possible to the V_{IN} and P_{GND} pins (see [Figure 16](#)). The example in [Figure 16](#) uses 1 x 1-nF 0402 25-V and 3 x 10-μF 1206 25-V ceramic capacitors (TDK Part # C3216X5R1C106KT or equivalent). Notice there are ceramic capacitors on both sides of the board with an appropriate amount of vias interconnecting both layers. In terms of priority of placement next to the power stage C5, C8 and C6, C19 should follow in order.
- The bootstrap cap C_{BOOT} 0.1-μF 0603 16-V ceramic capacitor should be closely connected between $BOOT$ and $BOOT_R$ pins.
- The switching node of the output inductor should be placed relatively close to the power stage CSD97374Q4M V_{SW} pins. Minimizing the V_{SW} node length between these two components will reduce the PCB conduction losses and actually reduce the switching noise level.⁽¹⁾

9.1.3 Thermal Performance

The CSD97374Q4M has the ability to use the GND planes as the primary thermal path. As such, the use of thermal vias is an effective way to pull away heat from the device and into the system board. Concerns of solder voids and manufacturability problems can be addressed by the use of three basic tactics to minimize the amount of solder attach that will wick down the via barrel:

- Intentionally space out the vias from each other to avoid a cluster of holes in a given area.
- Use the smallest drill size allowed in your design. The example in [Figure 16](#) uses vias with a 10-mil drill hole and a 16-mil capture pad.
- Tent the opposite side of the via with solder-mask.

In the end, the number and drill size of the thermal vias should align with the end user's PCB design rules and manufacturing capabilities.

(1) Keong W. Kam, David Pommerenke, "EMI Analysis Methods for Synchronous Buck Converter EMI Root Cause Analysis", University of Missouri – Rolla

9.2 Layout Example

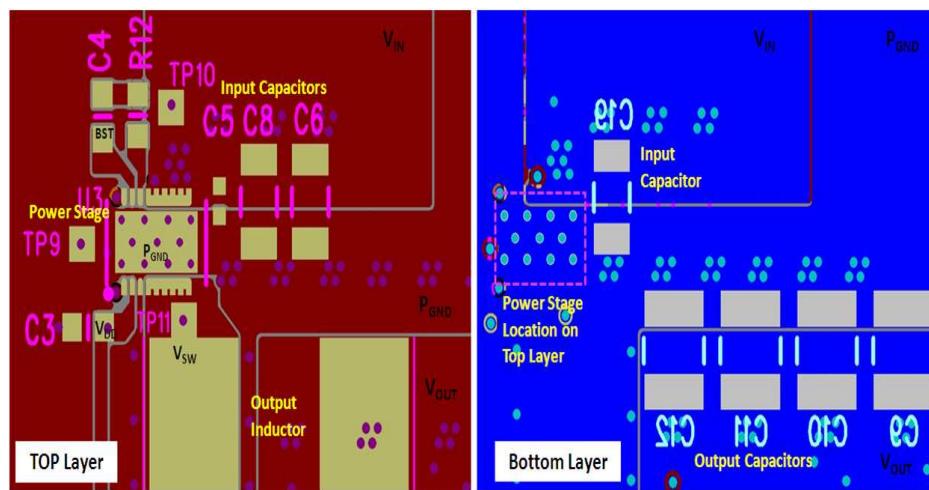


Figure 16. Recommended PCB Layout (Top Down View)

10 器件和文档支持

10.1 接收文档更新通知

如需接收文档更新通知, 请导航至 TI.com 上的器件产品文件夹。单击右上角的通知我 进行注册, 即可每周接收产品信息更改摘要。有关更改的详细信息, 请查看任何已修订文档中包含的修订历史记录。

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下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范, 并且不一定反映 TI 的观点; 请参阅 TI 的 [《使用条款》](#)。

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设计支持 [TI 参考设计支持](#) 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

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10.5 Glossary

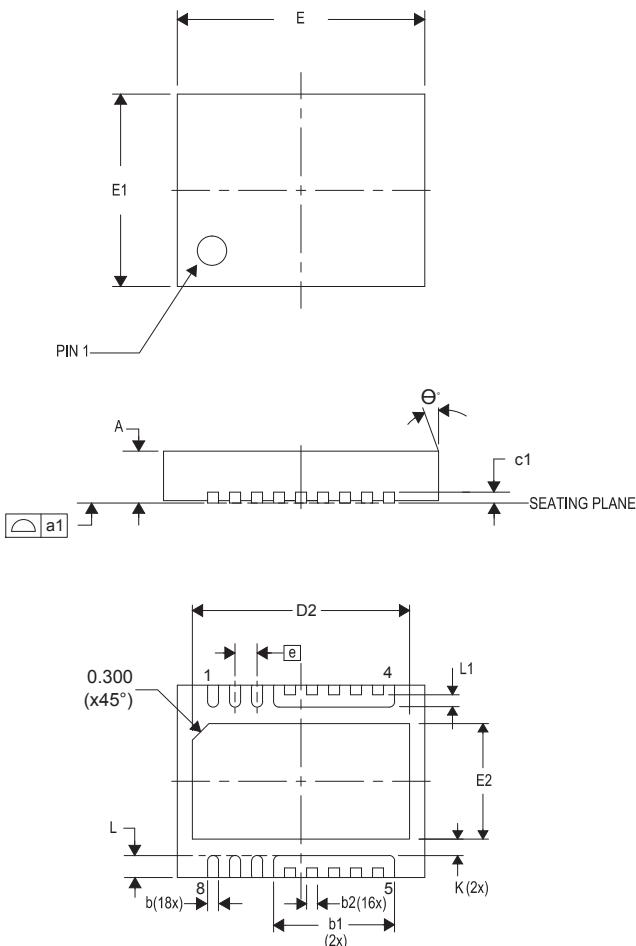
[SLYZ022 — TI Glossary](#).

This glossary lists and explains terms, acronyms, and definitions.

11 机械封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知和修订此文档。如欲获取此数据表的浏览器版本，请参阅左侧的导航。

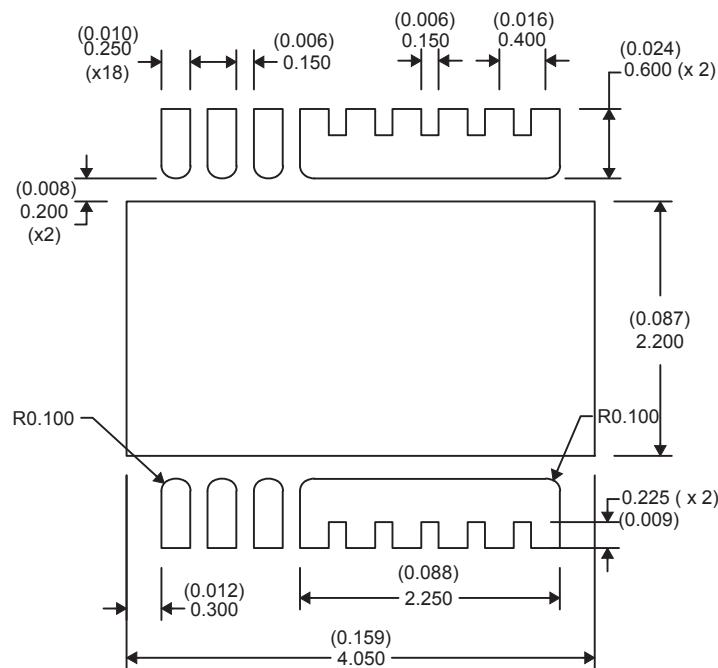
11.1 机械尺寸



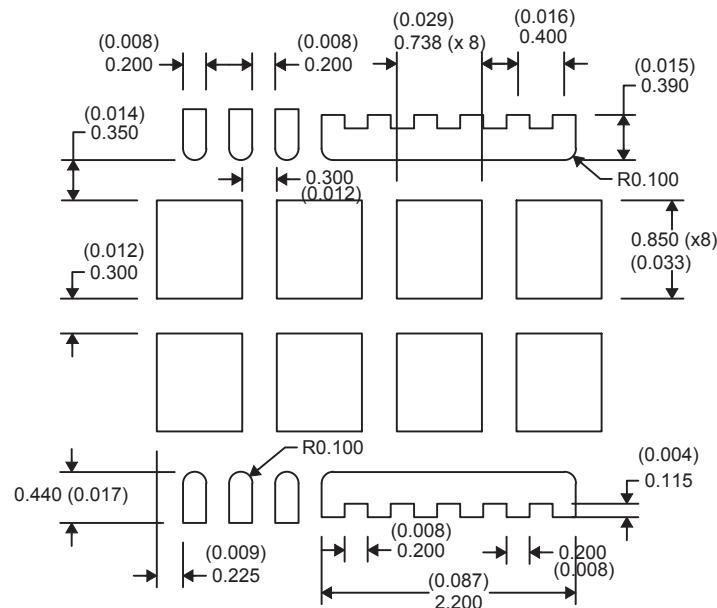
DIM	毫米			英寸		
	最小值	标称值	最大值	最小值	标称值	最大值
A	0.800	0.900	1.000	0.031	0.035	0.039
a1	0.000	0.000	0.080	0.000	0.000	0.003
b	0.150	0.200	0.250	0.006	0.008	0.010
b1	2.000	2.200	2.400	0.079	0.087	0.095
b2	0.150	0.200	0.250	0.006	0.008	0.010
c1	0.150	0.200	0.250	0.006	0.008	0.010
D2	3.850	3.950	4.050	0.152	0.156	0.160
E	4.400	4.500	4.600	0.173	0.177	0.181
E1	3.400	3.500	3.600	0.134	0.138	0.142
E2	2.000	2.100	2.200	0.079	0.083	0.087
e	0.400 典型值			0.016 典型值		
K	0.300 典型值			0.012 典型值		
L	0.300	0.400	0.500	0.012	0.016	0.020

DIM	毫米			英寸		
	最小值	标称值	最大值	最小值	标称值	最大值
L1	0.180	0.230	0.280	0.007	0.009	0.011
θ	0.00	—	—	0.00	—	—

11.2 推荐 PCB 焊盘图案



11.3 建议模板开口



NOTE: 尺寸单位为 mm (英寸)。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD97374Q4M	Active	Production	VSON-CLIP (DPC) 8	2500 LARGE T&R	ROHS Exempt	NIPDAU SN	Level-2-260C-1 YEAR	-40 to 150	97374M
CSD97374Q4MG4	Active	Production	VSON-CLIP (DPC) 8	2500 LARGE T&R	ROHS Exempt	NIPDAU	Level-2-260C-1 YEAR	-40 to 150	97374M

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

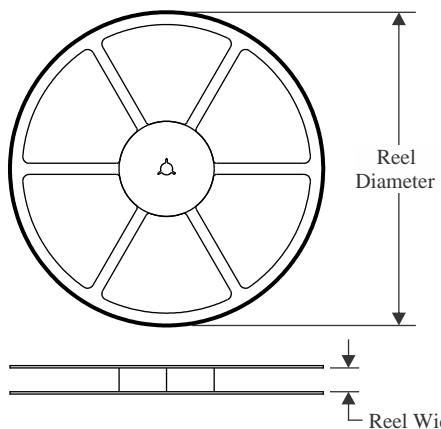
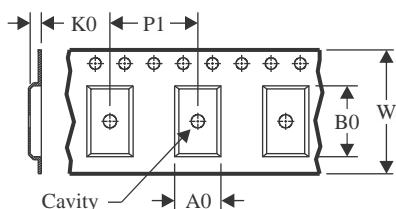
⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

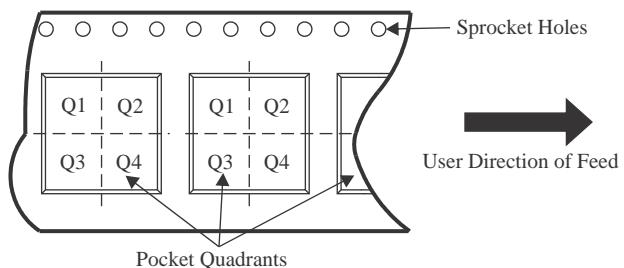
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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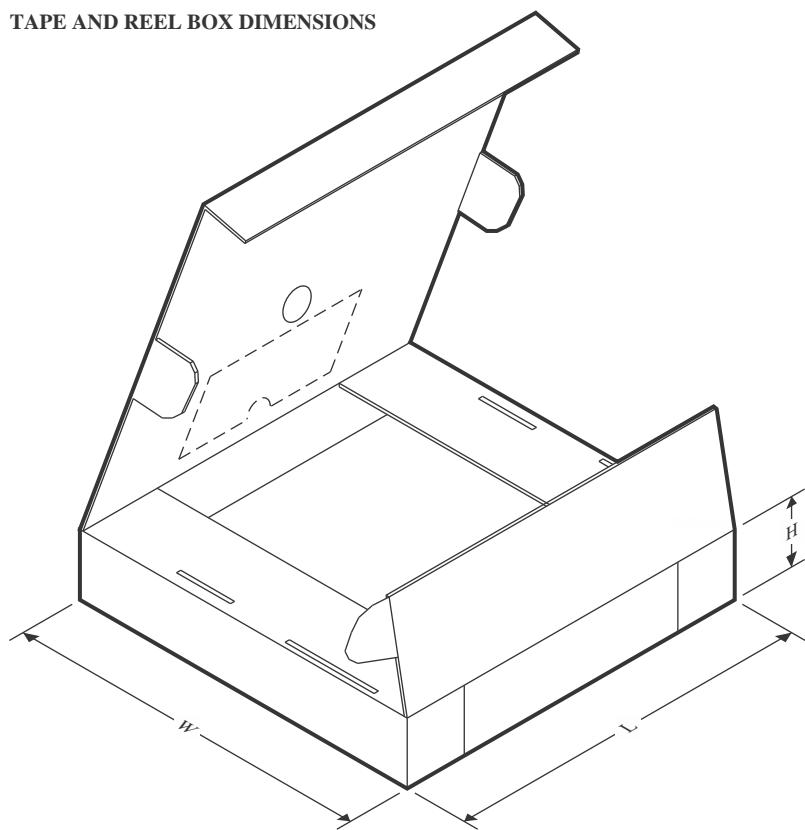
TAPE AND REEL INFORMATION
REEL DIMENSIONS

TAPE DIMENSIONS


A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD97374Q4M	VSON-CLIP	DPC	8	2500	330.0	12.4	3.71	4.71	1.1	8.0	12.0	Q1
CSD97374Q4MG4	VSON-CLIP	DPC	8	2500	330.0	12.4	3.71	4.71	1.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD97374Q4M	VSON-CLIP	DPC	8	2500	346.0	346.0	33.0
CSD97374Q4MG4	VSON-CLIP	DPC	8	2500	346.0	346.0	33.0

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